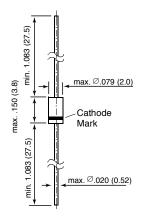
1N4151

SMALL SIGNAL DIODES

DO-35



FEATURES

- ♦ Silicon Epitaxial Planar Diode
- ♦ Fast switching diode.
- ◆ This diode is also available in other case styles including the SOD-123 case with the type designation 1N4151W and the Mini-MELF case with the type designation LL4151.



MECHANICAL DATA

Case: DO-35 Glass Case Weight: approx. 0.13 g

Dimensions in inches and (millimeters)

MAXIMUM RATINGS

Ratings at 25°C ambient temperature unless otherwise specified.

	SYMBOL	VALUE	Volts	
Reverse Voltage	VR	50		
Peak Reverse Voltage	V _{RM}	75	Volts	
Rectified Current (Average) Half Wave Rectification with Resist. Load at Tamb = 25 °C and f ≥ 50 Hz	lo	150 ⁽¹⁾	mA	
Surge Forward Current at t < 1s and T _j = 25°C	IFSM	500	mA	
Power Dissipation at Tamb = 25°C	P _{tot}	500 ⁽¹⁾	mW	
Junction Temperature	Tj	175	°C	
Storage Temperature Range	Ts	- 65 to +175	°C	

NOTES:

(1) Valid provided that leads at a distance of 8 mm from case are kept at ambient temperature



1N4151

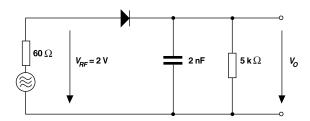
ELECTRICAL CHARACTERISTICS

Ratings at 25 $^{\circ}\text{C}$ ambient temperature unless otherwise specified

	SYMBOL	MIN.	TYP.	MAX.	UNIT
Forward Voltage at IF = 50 mA	VF	_	_	1.0	Volts
Leakage Current at $V_R = 50 \text{ V}$ at $V_R = 50 \text{ V}$, $T_j = 150 \text{ °C}$	I _R IR	_ _	_ _	50 50	nA μA
Reverse Breakdown Voltage Tested with 5µA pulses	V(BR)R	75	_	_	Volts
Capacitance at VF = VR = 0 V	Ctot	-	-	2	pF
Reverse Recovery Time from IF = 10 mA to IR = 1 mA from IF = 10 mA to IR = 1 mA, $VR = 6 V$, $RL = 100 \Omega$	t _{rr} trr	_ _	_ _	4 2	ns ns
Thermal Resistance Junction to Ambient Air	Roja	_	_	350 ⁽¹⁾	°C/W
Rectification Efficiency at f = 100 MHz, V _{RF} = 2 V	ην	0.45	-	-	-

NOTES:

(1) Valid provided that electrodes are kept at ambient temperature.

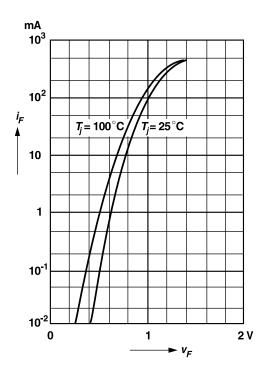


Rectification Efficiency Measurement Circuit



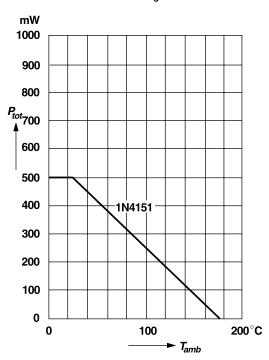
RATINGS AND CHARACTERISTICS CURVES 1N4151

Forward characteristics

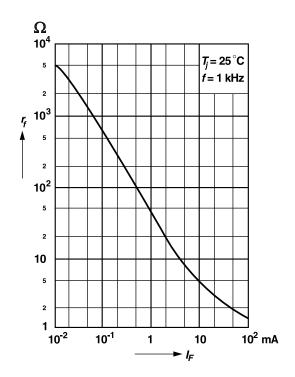


Admissible power dissipation versus ambient temperature

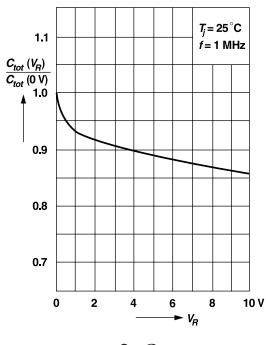
For conditions, see footnote in table "Absolute Maximum Ratings"



Dynamic forward resistance versus forward current



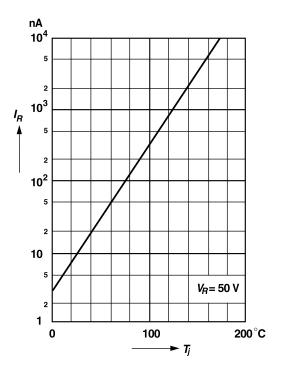
Relative capacitance versus reverse voltage





RATINGS AND CHARACTERISTICS CURVES 1N4151

Leakage current versus junction temperature



Admissible repetitive peak forward current versus pulse duration

For conditions, see footnote in table "Absolute Maximum Ratings"

